

1 **Thin Film Thickness Measurements in Two Phase Annular Flows using Ultrasonic**
2 **Pulse Echo Techniques.**

3 Y. A. Al-aufi¹, B. N. Hewakandamby¹, G. Dimitrakis¹, M. Holmes², A. Hasan³ N. J. Watson¹ *

4 ¹ Faculty of Engineering, University of Nottingham, University Park, Nottingham NG7 2RD, UK

5 ² School of Food Science and Nutrition, University of Leeds, Woodhouse lane, Leeds LS29JT, UK

6 ³ Faculty of Science and Engineering, University of Hull, Cottingham road, Hull HU67RX, UK

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8 *Corresponding Author.

9 Address: Dr Nicholas James Watson. Room B16, Coates Building, University Park, University of
10 Nottingham, Nottingham, Nottinghamshire, NG7 2RD, UK.

11 Email: nicholas.watson@nottingham.ac.uk

12 Phone: (+44) 115 74 84848

13

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16

17 **Abstract:**

18 The electric power generation and oil/gas production industries have a strong interest in the physical
19 characterization of conducting and non-conducting liquid films that are formed during the flow of liquids
20 in pipes. Conducting and non-conducting liquid films do not lend themselves to the same characterization
21 techniques due to the different requirements originating from their electrical properties. Techniques
22 based on the use of ultrasound are extremely attractive for that purpose as they do not depend on the
23 electrical properties of the liquid and are also non-invasive. This paper presents the application of
24 ultrasonic techniques for measuring the thickness of wavy thin liquid films (<6 mm) in vertical pipes. Initial
25 benchtop experiments were performed, and different signal processing methods were implemented in
26 order to identify the most suitable depending on the film thickness. For a film thickness >0.5 mm a time
27 of flight method was utilized whereas for a film thicknesses <0.5 mm a frequency method and time domain
28 method were utilized. These methods were validated using a theoretical volume measurement on a static
29 system. The studied methods were then tested on downward and upward vertical flow experimental rigs
30 with pipe diameters of 127mm and 34.5mm respectively. The results of the experiments using ultrasonic
31 methods showed good agreement with the measurements obtained using a multi pin film sensor and a
32 concentric conductance probe, highlighting the potential that ultrasound offers in thin film
33 measurements.

34 *Keywords: Thin Liquid Film Thickness, Ultrasonic measurements, Two-phase flow*

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38 **1. Introduction:**

39 Two phase flows (e.g. liquid and gas) are common in nature as well as in industrial applications [1]. Despite
40 their importance they are still one of the least understood areas of fluid mechanics due to the complexities
41 of the deforming interfaces and the dynamic dispersity of the phases within each other. However, models
42 that apply to various flow regimes supported by system specific correlations based on measurements exist
43 and are used in process and equipment design. The integrity of the data, therefore, is paramount to the
44 success of the design and the predictability of the flow. Most of the correlations in use are developed
45 using water as the liquid phase and steam or air as the gaseous phase in gas-liquid two phase flow systems.
46 The universality of these correlations is yet to be proven as most seem to be system specific. For this
47 particular reason, correlations, specifically the fitting constants, are generally established through
48 measurements for various liquid flows where the physical properties are often different from water.

49 Annular flow is the most frequently observed two phase flow regime [2]. Risers in oil platforms, boiler
50 tubes in power generation, and industrial condensers are all industrial examples that experience annular
51 flow. In annular flow, the liquid flows partly as a thin film along the pipe wall and partly as droplets
52 entrained in the turbulent gas core. The film is driven by the interfacial shear imparted by the gas flow
53 and this coupling of momentum between the two phases leads to various interfacial behaviors [2]. While
54 there are capillary waves propagating on the film, large coherent waves (in pipes with small diameters)
55 travel on the film intermittently, at a much larger speed. These waves are often called disturbance or roll
56 waves. Though intermittent, these waves seem to have somewhat regular periodicity for given liquid and
57 gas flow rates [2, 3, 4]. The highly dynamic, complex interfacial phenomena, which are dependent on the
58 gas and liquid flow rates and the physical properties of the two phases present one of the greatest
59 challenges in developing theoretical models describing the hydrodynamics of the film [4]. However,
60 capturing the characteristics of the liquid film is essential for the development of predictive models [1, 2]
61 used for efficient and safe equipment design and operation. To this end, phenomenological models
62 underpinned by the measurements of the local film thickness and flowrates should be developed. Local
63 liquid film thickness measurements provide information to estimate the gas void fraction, hence the liquid
64 and gas velocities [5]. Furthermore, such measurements provide means to test the existing correlations
65 for their fidelity.

66 There has been substantial experimental research studying the behaviour of annular flow and readers can
67 refer to the reviews of Azzopardi [3], Clark [6] and Berna et al. [7] for further details. The majority of
68 previous work has focussed on liquid gas annular flow but two liquid annular flows have been studied and
69 reviewed by Ghosh et al. [8]. The previous research has focussed on studying the annular thin film
70 thickness and the features of the disturbance waves (frequency, amplitude/height and velocity). The
71 features of the disturbance waves have received interest as they have significant effects on heat and mass
72 transfer between the gas and liquid phases which is essential to understand, for industrial applications
73 such as condensers and evaporators [9]. The measurement methods used to study the film and wave

74 features have been classified by Clark [6] as film averaged methods, localised methods and point methods.
75 Film average methods measure the volume of liquid in a section of pipe by isolating it using valves at
76 either end of the section under investigation. These techniques can be used to calculate average film
77 thicknesses but do not provide information on the characteristics of the disturbance waves. Localised and
78 point methods are more common in the literature as they can be used to determine spatial and temporal
79 characteristics of the liquid film and disturbance waves. Localised and point methods differ as localised
80 methods perform measurements over a defined spatial region whereas point methods perform
81 measurements at a single spatial location. Different sensors methods have been used to study film
82 thickness and disturbance waves including a variety of optical techniques [6,7, 10-15], conductance or
83 capacitance sensors techniques [16, 17], ultrasonic methods [18] or those that place tracer materials
84 (often radioactive) within the fluid [19]

85 Results from previous experimental work has shown that these different measurements can successfully
86 be used to characterise the film and disturbance wave features in annular flow. Zadrazil et al. [10] showed
87 that planar laser induced florescence measurements could be used to measure the frequency and
88 amplitude of disturbance waves in upward annular flow. Pham et al. 2016 [11] and Kunugi et al. [15]
89 showed that a high speed camera could be used to study the effect that spacers within a pipe section had
90 on disturbance waves. Pan et al. [13] used high speed photography in vertical upward gas liquid annular
91 flow to show that increases in gas velocity reduced the film thickness. Vasques et al. [9] studied upward
92 and downward gas/liquid annular flow and used measurements from a brightness based laser induced
93 florescence technique to demonstrate that the disturbance wave behaviour was dependent on flow
94 direction. Wang et al. [14] used Near-Infrared measurements at two points to study the velocity of
95 disturbance waves at different gas pressures in vertical upwards gas/liquid flow. Belt [17] used
96 conductance probes at 32 circumferential locations and 10 axial locations to study disturbance wave
97 features in upward gas liquid annular flow. Although the majority of work has focussed on the film and
98 wave features several researchers have studied the entrainment of liquid droplets into the gas core. For
99 more details on liquid entrainment the reader can refer to the review of Berna et al. [7]

100 Many of the liquid film measurement techniques have been developed using water as a liquid phase by
101 exploiting the advantage of its electrical properties (i.e high conductivity). These work are also often
102 performed in transparent pipes. Therefore, the developments of techniques that can operate with a non-
103 conducting medium such as oil and in systems with opaque pipe wall materials are required. In this
104 present study water and silicone oil were used as the liquid phases. Silicone oil was selected as its physical
105 properties resemble typical process liquids used in the oil and gas industry and is an electrically non-
106 conducting fluid. Water was also utilized so experimental results could be compared to those in the
107 literature which generally use water as the liquid phase.

108 In the present work, an ultrasonic pulse echo technique has been applied to measure the liquid film
109 thickness where the signal is transmitted and received by the same transducer. It is a non-intrusive
110 measurement technique that can easily be attached to different locations on the pipe and operates on
111 opaque materials such as PVC and metals. The ultrasonic pulse echo technique has been used by Chun et
112 al. [18] to investigate the effects of wall thickness, wall material, and ultrasonic frequency on liquid film
113 thickness measurements. They also compared the technique against theoretical calculations using static

114 films on plate and tube test sections. They concluded that the ultrasonic pulse echo technique can be used
115 when the tube wall thickness ($\delta_{w,min}$) is greater than the value specified by:

$$116 \quad \delta_{w,min} \geq N c_w / 2f \quad (1)$$

117 Where N is the number of wave cycles in the ultrasonic pulse, c_w is the speed of ultrasonic wave in the
118 wall material and f is the frequency of ultrasonic wave. If the tube wall thickness is greater than this value
119 the reflected waves are superimposed upon one another and signal and data analysis becomes
120 challenging. This study also concluded that the acoustic impedance mismatch between the wall material
121 and the liquid film should be low enough to allow the signals to be transmitted into the liquid film and the
122 reflected signal from the liquid film/air interface distinguishable. Lu et al. [20] measured condensate film
123 thickness using an ultrasonic pulse echo technique in a horizontal rectangular test section. They indicated
124 that the ultrasonic measurements for wavy films could be improved by increasing the data acquisition
125 rate (received waves/second). Serizawa et al. [21] evaluated ultrasonic measurements against a laser
126 displacement gauge and impedance probe in stratified flow over a horizontal plate test section. They
127 found an excellent agreement between the three measurement techniques. However, they indicated that
128 the ultrasonic measurement has poor detection sensitivity due to the varying angle of the reflection
129 interface. Chen et al. [22] used ultrasonic measurements to monitor the dynamic behavior of condensing
130 and non-condensing fluid films. They proposed a new data processing method based on spectral analysis
131 using a Fourier Transform to measure film thicknesses from 50 to 750 μm . Ultrasonic techniques have also
132 been employed in two phase flow by many researchers to identify flow regimes [23-27]. However, most
133 of the research was performed using ultrasonic techniques to measure liquid film thicknesses greater than
134 1mm and to identify the flow regimes on a horizontal pipe using air/water systems.

135 In the present study, the capability of the ultrasonic technique for measuring liquid film thicknesses in the
136 range of 0.1 to 6 mm was examined for static films (in bench top experiments) as well as for dynamic films
137 in annular flow within a cylindrical pipe. A Time of Flight (TOF) method was utilised for film thicknesses
138 >0.5 mm, whereas time domain and frequency domain methods were used for film thicknesses <0.5 mm.
139 The ultrasonic measurements were compared with a Multi Pin Film Sensor (MPFS) and a concentric
140 conductance probe in both a downward and upward vertical flow rig using an air/water system, to assess
141 its accuracy and applicability to dynamic films.

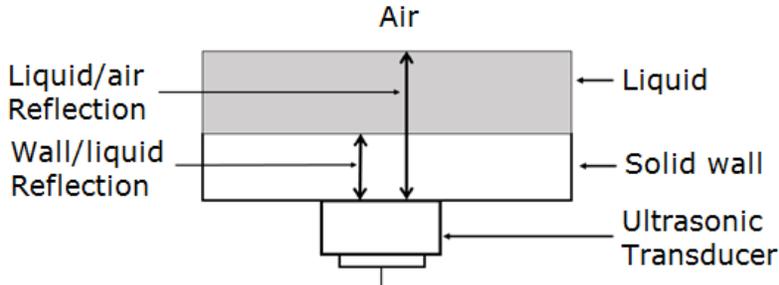
142 **2. Principle of Ultrasonic Pulse Echo Techniques:**

143 Ultrasonic techniques operate by transmitting low amplitude, high frequency acoustic waves through the
144 system under investigation [28]. Ultrasonic pulse echo techniques can be used to calculate distances by
145 measuring the time difference between transmitted and reflected pulses and knowledge of the speed of
146 sound in the medium. This can be better demonstrated by studying a system consisting of three different
147 layers as shown in Figure 1. These three layers are a solid wall, a liquid film and air. An ultrasonic
148 transducer is attached to the solid wall. When an ultrasonic pulse is transmitted from the transducer, it
149 will be partly reflected at the solid wall/liquid interface and received back by the same transducer as
150 shown in Figure 1. The remaining acoustic energy will be transmitted through the liquid and then reflected
151 back from the liquid film/air interface to also be received by the transducer. The Time of Flight (TOF) (Δt)

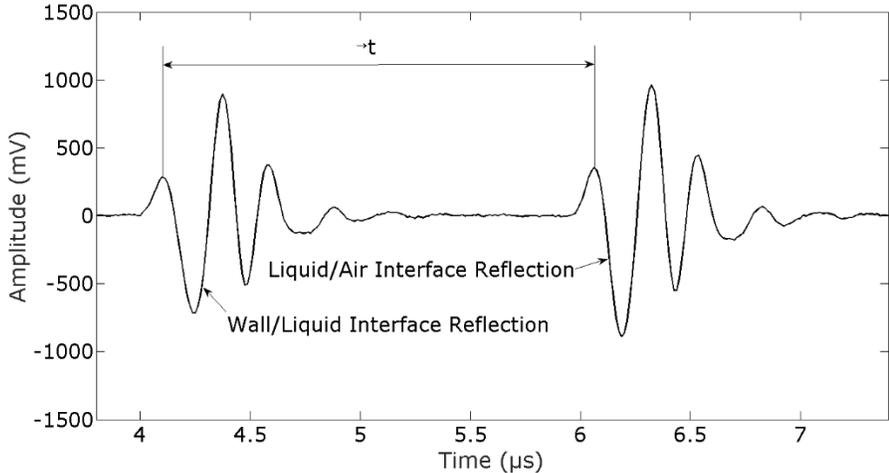
152 of the ultrasonic wave through the liquid film can be determined by recording the time difference
 153 between the first reflected pulse at the solid wall/liquid film interface and the first reflected pulse at liquid
 154 film/air interface (Figure 2). The liquid film thickness (δ) can then be calculated from the measurement of
 155 the TOF using:

156
$$\delta = C_L \Delta t / 2 \tag{2}$$

157 Where C_L is the ultrasonic wave speed of sound in the liquid phase.



158
 159 Figure 1: Schematic of pulse echo technique showing the two reflections of the ultrasonic pulse in a
 160 system consisting of three different layers (solid wall, liquid film and air).



161
 162 Figure 2: Ultrasonic reflected signals from wall/liquid and liquid/air interfaces showing the time
 163 difference between them.

164 Care must be taken to ensure the correct reflected pulse is used for calculations. Acoustic reverberations
 165 exist within the solid wall, but the liquid/air interface can be identified by varying the thickness of the
 166 liquid layer. The TOF method can only be used when the two reflected signals do not overlap in time.
 167 Therefore, the TOF is useful for films having a thickness greater than half the pulse wavelength, multiplied
 168 by the number of cycles in the pulse. This is approximately 0.45 mm for a water film while using a 5 MHz
 169 transducer with three cycles in the pulse.

170 For thin films (<0.5 mm) the reflected signal will become overlapped in time and alternative signal
171 processing strategies are required. There has been a variety of work in the literature using ultrasonic
172 methods to measure thin films with applications in lubricants (29, 30), Condensing films (22), adhesive
173 layers (31) and multilayer systems (32, 33). Numerous methods have been used to calculate the film or
174 layer thicknesses from the ultrasonic measurements including resonance methods (22, 29, 35), spring
175 models (29, 34, 35), wavelet analysis (36, 37), fractional Fourier Transforms (38) and matching pursuit
176 methods (31, 39). The proposed methods process the signals in the time or frequency domain or use a
177 method which is a combination of both. Time domain methods generally focusses on identifying the
178 individual reflections in the overlapped waves using deconvolution methods (40). Spring model methods
179 have been used extensively to measure thin films (~0.01-20 μm) between two solid materials by
180 calculating reflection coefficients as a function of frequency. The capability of the measurement system
181 depends on the frequency of the transducer utilised. The spring model also requires a reference signal
182 which is a reflection from an interface of known properties which is not always possible in some
183 experimental and real-life systems. The spring model can also be used for multilayer systems when
184 applying the Gaussian echo pre-processing steps suggested by (40).

185 The majority of previous work has been on a thin layer bounded by two stationary solid materials of known
186 properties. This is not the case for gas/liquid annular flow where the liquid is flowing and has a different
187 material of either side. An additional level of complexity is involved as the liquid/gas interface is in a
188 constant state of change with the presence of disturbance waves. In this work we will study two different
189 signal processing methods for thin films, one in the frequency domain and one in the time domain. The
190 frequency domain method will use the technique developed by Chen et al. [22] and the time domain
191 method will focus on the technique used by Park et al. [41]. These methods were selected as they have
192 been used previous on solid/liquid/gas systems which most closely represent the annular flow we will
193 study.

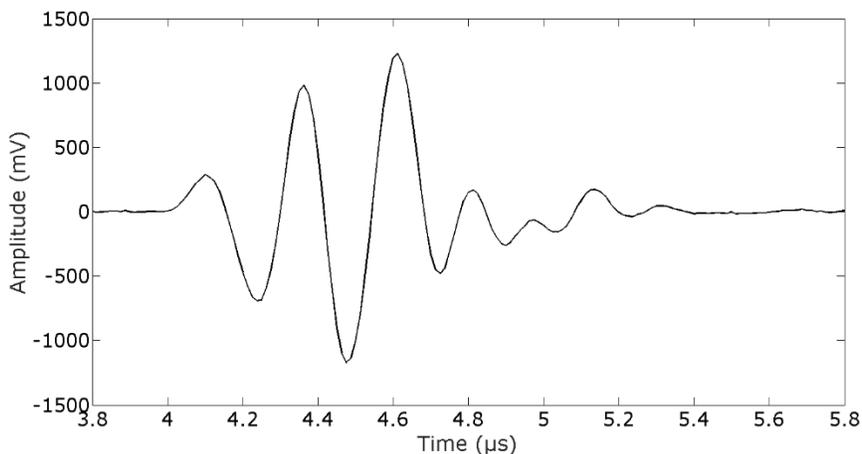
194 **2.1 Frequency domain method:**

195 For a thin film thickness less than 0.5mm, a frequency domain method developed by Chen et al. [22] can
196 be used. The thin liquid film (δ) can be calculated from:

$$197 \quad \delta = C_L/4f_0 \quad (3)$$

198 Where f_0 is the lowest frequency in the spectral data. As this cannot often be detected f_0 is taken as half
199 of the average interval distance between each pair of adjacent spectral peaks. The method of Chen et al.
200 [22] requires numerous signal processing steps to calculate f_0 . First, a baseline signal is subtracted from
201 the received signals. This baseline is a signal recorded from a liquid film with infinite thickness. This
202 contains only a single reflection from the wall/liquid interface which is located at the same position for all
203 measurements made during the experiments. The remaining signal is then multiplied by a “flat top”
204 window function. This is performed by a point-by-point multiplication. The center half of the signal is
205 multiplied by one while both the beginning and end quarters were multiplied by coefficients which taper
206 from one at the center to zero at the ends. The flat top function is used to improve the signal to noise
207 ratio. The next step requires the signal to be zero padded to ensure it contains a number of samples which

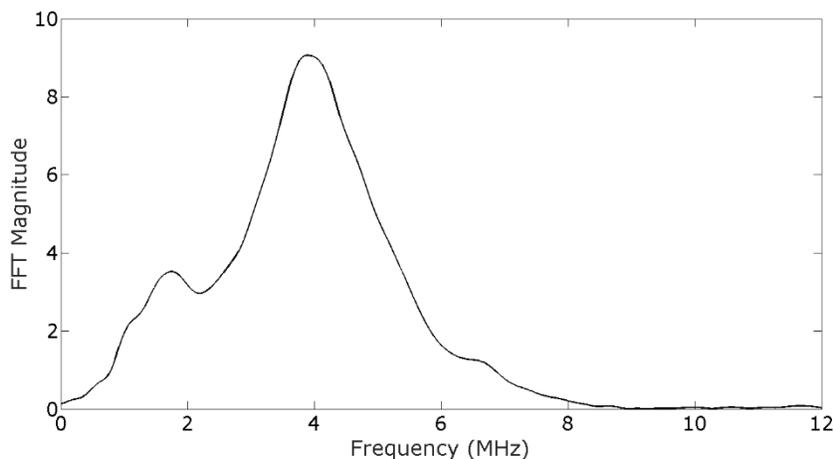
208 is a power of two. This is performed to improve the efficiency of the following step which is to calculate
209 the Fast Fourier Transform (FFT) of the signal. The FFT creates a power density spectrum, and the
210 frequencies of the main spectral peaks are identified. The interval between each pair of adjacent spectral
211 peaks is calculated and all intervals in a given spectrum are averaged. The average interval is divided by
212 two to determine f_0 , which is then used to calculate the layer thickness using Equation (3). An example of
213 an overlapped waveform signal (Figure 3a) and frequency spectrum after applying the frequency method
214 (Figure 3b) for a 0.2 mm liquid film thickness is shown in Figure 3. The three main frequency spectrum
215 peaks are identified at approximately 1.8, 4.1 and 6.4 MHz.



216

217

(a)



218

219

(b)

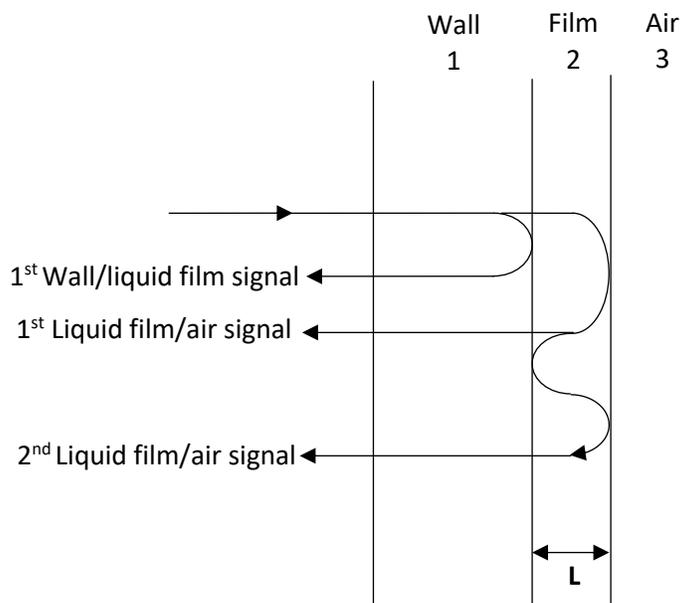
220 Figure 3: Original overlapped reflected waveform signal (a) and frequency spectrum after applying the
221 frequency method (b) for a 0.2 mm liquid film thickness

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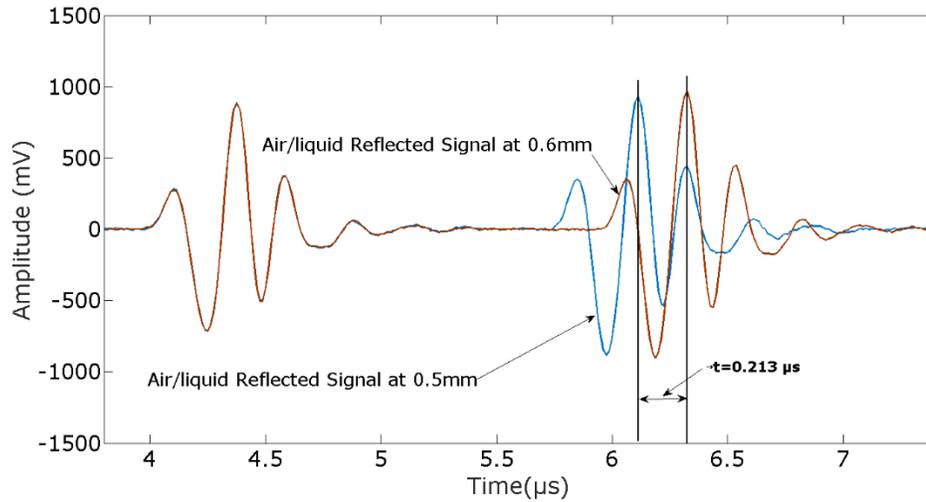
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224 **2.2 Time Domain (Baseline removal) method:**

225 The measurement of the film thickness using a TOF method (Equation 2) depends on identifying the first
 226 wall/liquid film reflected signal and the first liquid film/air reflected signal. When the liquid film is less
 227 than 0.5mm, the first liquid film/air reflected signal will overlap in time with the first wall/liquid film
 228 reflected signal (for a 5Mhz 3 cycle pulse). This makes the two reflected signals interfere with each other
 229 and results in a signal which includes components reflected from both interfaces. However, there is a time
 230 difference between the two reflected signals where the first wall/liquid film reflected signal will always
 231 arrive before the first liquid film/air reflected signal. Figure 4 displays a three layer system (wall/liquid
 232 film/air). The first wall/liquid film reflected signal arrives after the wave propagates through the wall and
 233 reflects from the wall/liquid interface. In contrast, the first liquid film/air reflected signal arrives after the
 234 wave propagates through the wall and the liquid film and reflects from the liquid film/air interface.
 235 Therefore, the difference between the two reflected signals is the time taken by the wave to propagate
 236 through the liquid film twice. As an example, if the minimum liquid film thickness (L) is 0.1mm, this means
 237 the time difference between the two reflected signals will be related to the time required for the wave to
 238 travel 0.2mm ($2L$). This can be demonstrated from the example given in Figure 5 which shows two
 239 reflected waves from different film thicknesses of silicone oil (0.5mm (blue line) and 0.6mm (orange line)).
 240 There is a 0.1mm difference of film thickness between the two waveforms and it can be observed that
 241 there is a time difference between the two signal's maximum amplitude by the approximate time interval
 242 of $2L$ which is equal to $0.213\mu\text{s}$.



243
 244 Figure 4: Diagram of the expected ultrasound wave paths for the three layers, a solid wall, a liquid film
 245 and air [17].

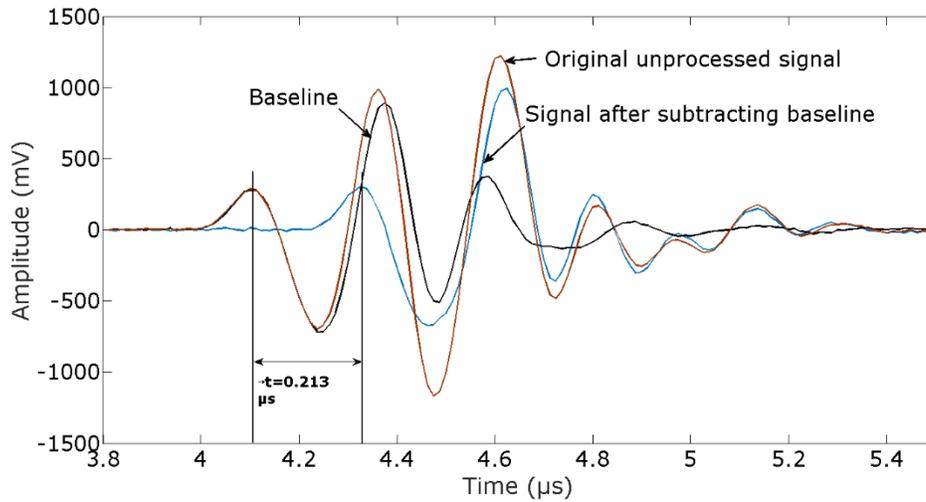


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247 Figure 5: Two measurement waveforms with a 0.1 mm difference in film thickness. The first wall/film
 248 signal is identical for the both two measurement waveforms (0.5mm (blue line) and 0.6mm (orange
 249 line)).

250 The first reflected wall/liquid film reflected signal is always at the same location with the same amplitude
 251 for all measurements of different liquid film thicknesses, as the wall has constant geometric dimensions.
 252 This was confirmed by plotting received signals through wall/liquid film/air systems with varying liquid
 253 film thicknesses (Figure 5). However, for the signal reflected from the wall/liquid interface to remain in a
 254 constant location the wall and liquid temperature should not be varied during the experiments. In
 255 addition, the transducer position should be kept fixed and vibrations within the test section should be
 256 eliminated or minimised. To identify the location of the wall/liquid film signal without interference from
 257 other reflections a film of relatively large thickness (>1 cm) can be generated and the received signals
 258 recorded. This signal is then labelled as the baseline. Once this baseline signal has been recorded
 259 experiments can be performed with thin film thicknesses on unknown size. The baseline removal method
 260 operates by subtracting the baseline signal from the recorded signals with unknown film thicknesses. This
 261 results in three signals: the baseline signal, the unprocessed signal and the signal after subtracting the
 262 baseline (Figure 6). The TOF through the liquid film can then be calculated by subtracting the time of the
 263 first signal peak from the baseline signal from the first signal peak of the processed signal and applying
 264 Equation 2.

265 To demonstrate the baseline removal method, Figure 6 shows an example of the method for a silicone oil
 266 film thickness of 0.1 mm. In Figure 6, the amplitude of three signals is plotted in the same figure with
 267 respect to time. The three signals are the original unprocessed overlapped signal (Red line), baseline signal
 268 (Black line) and the processed signal after subtracting the baseline signal (Blue line). From Figure 6, it can
 269 be observed that the time difference between the two reflected signals is 0.213 μs which is the same as
 270 the value demonstrated in Figure 5.



271

272 Figure 6: Ultrasound signals illustrating the baseline removal method for a film thickness of 0.1 mm.
 273 Original unprocessed signal (Red line), Baseline (Black line) and Signal after subtracting baseline (Blue
 274 line).

275 3. Experiment Setup:

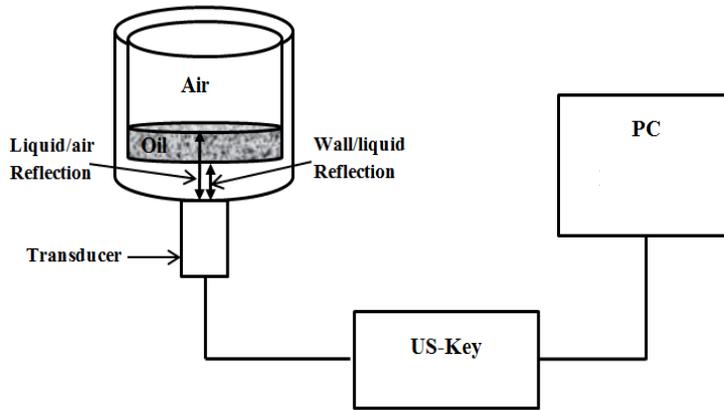
276 The ultrasonic pulse-echo technique was validated using static and dynamic measurements. In the static
 277 measurements, the ultrasonic technique was validated using a benchtop experiment using water and
 278 silicone oil (4.4 cP) as the fluids. The ultrasonic technique was also validated against two other well-known
 279 measurement techniques based on conductance measurements using an air/water system under dynamic
 280 conditions. Each method of validation will be discussed in detail in the following subsections.

281 4.1. Static Measurement:

282 The ultrasonic technique was validated using silicone oil (4.4 cP) as shown in the schematic diagram in
 283 Figure 7. The validation was for static fluid conditions with film thicknesses between 0.1 mm and 6 mm.
 284 A cylindrical test section made of acrylic resin Perspex (Internal Diameter = 24.8 mm, wall thickness=5 mm
 285 and Height= 20 mm) was used. A Technisonic transducer model IPM-0502-HR 5MHz was used for these
 286 experiments. This was located in the centre of the bottom external surface of the test section. The
 287 diameter of the test section was measured using a digital caliper with an accuracy of +/-0.01 mm, and the
 288 volume was measured using a Gilson's Pipetman Classic with an accuracy of +/-2 μL. In the current study,
 289 a US-KEY (Lecoeur Electronique) was used as the transmitter, receiver and digitiser. The received signals
 290 were recorded and the film thicknesses calculated using bespoke MATLAB code based on the
 291 methodologies described above. The thickness of the film measured by the ultrasonic technique was
 292 compared with those calculated theoretically using:

$$293 \quad \delta_{th} = V/A \quad (4)$$

294 Where δ_{th} is theoretical film thickness (mm), V is the volume (mm³) and A is the cross-sectional area (mm²).



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Figure 7: Schematic diagram of the static experiment using a cylindrical test section.

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Silicone oil with 4.4 cP viscosity was used as it can generate film thicknesses less than 1 mm. It was difficult to generate thin films less than 1 mm using water due to surface tension effects. The speed of sound of the silicone oil at temperatures ranging between 10 and 45°C at atmospheric pressure was measured using a TF instruments RESOSCAN as shown in Figure 8. These measurements were required to account for any temperature effects on the sound propagation velocity during the experiments. The measurement of silicone oil speed of sound was repeated three times during heating and cooling and the maximum speed of sound coefficient of variation was within 0.02%. The coefficient of variation is defined as the ratio of the standard deviation to the mean.

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The speed of sound in silicone oil can be calculated using equation (5) based on repeated measurements obtained using the TF instruments RESOSCAN.

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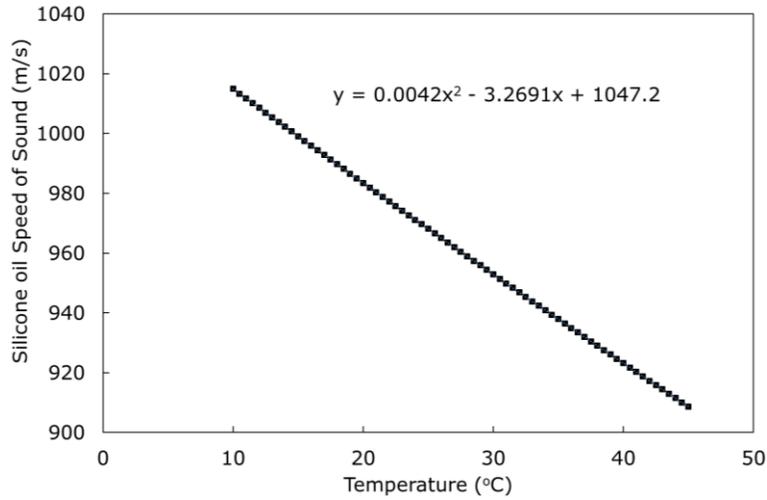
$$C_l = 1.0472 \times 10^3 - 3.2691T + 4.2 \times 10^{-3}T^2 \quad (5)$$

308

309

Where T is the temperature in degrees Celsius. This equation is valid for temperature range 10-45°C at atmospheric pressure.

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Figure 8. Speed of sound of silicone oil (4.4cP) for a temperature range of 10-45°C at atmospheric pressure.

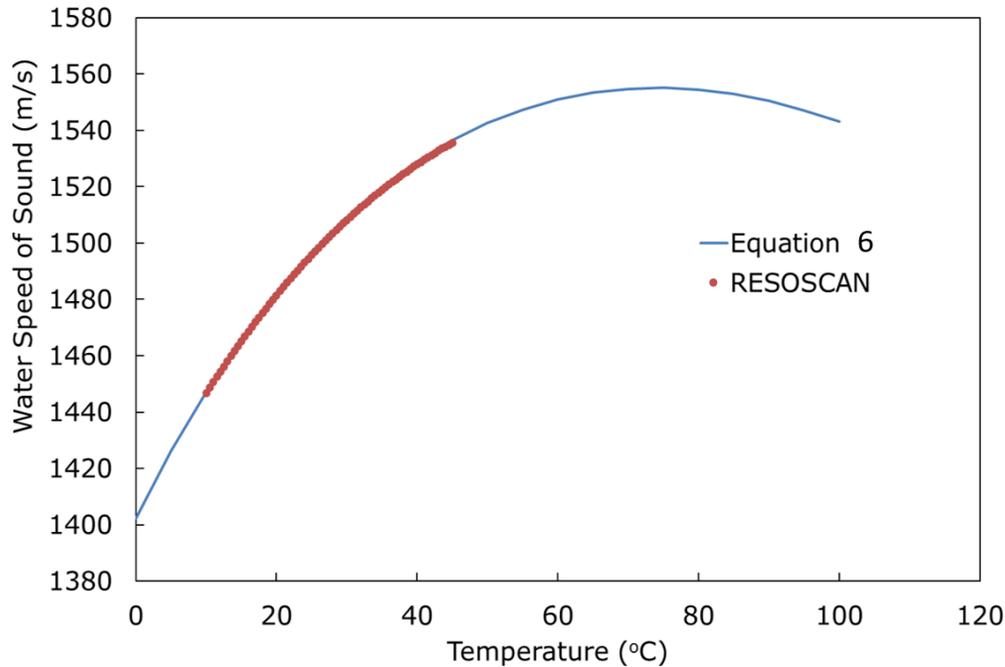
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314 The RESOSCAN measurements were validated by measuring the speed of sound of distilled water for a
 315 temperature range of 10-45°C at atmospheric pressure and comparing with those available in the
 316 literature [42]. The results are shown in Figure 9. The relative deviation between RESOSCAN and Equation
 317 6 was ±0.04%.

318 $C_L = 1.40238677 \times 10^3 + 5.03798765T - 5.80980033 \times 10^{-2}T^2 + 3.34296650 \times 10^{-4}T^3 -$
 319 $1.47936902 \times 10^{-6}T^4 + 3.14893508 \times 10^{-9}T^5$ (6)

320 Where T is the temperature in degrees Celsius. This equation is valid for a temperature range of 0-100°C
 321 at atmospheric pressure.

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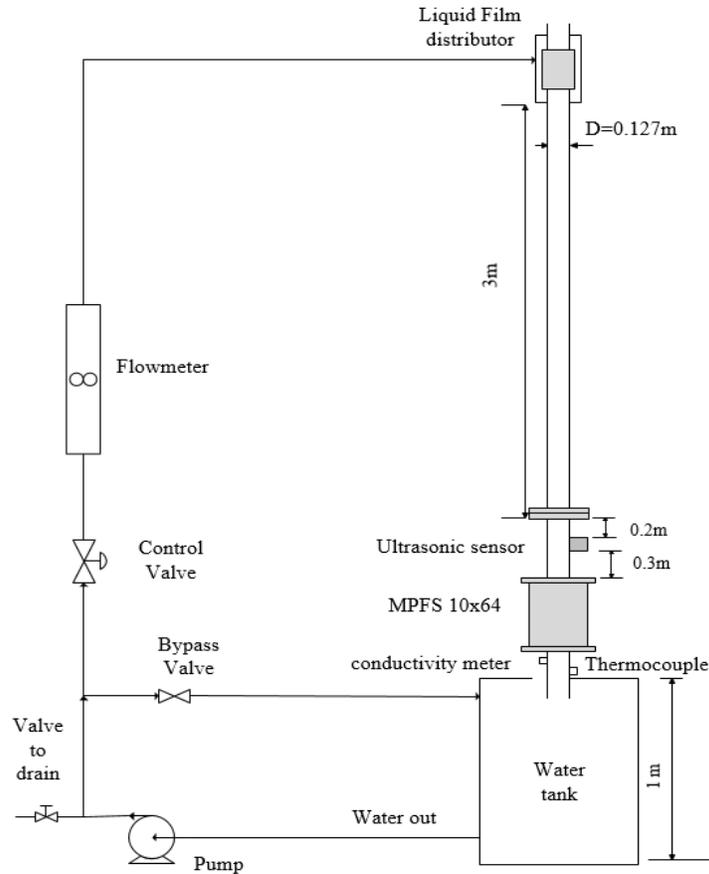
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324 Figure 9: Comparison of speed of sound measurements in water using a RESOSCAN with literature
 325 (Equation 6).

326 Distilled water was also used to validate the film thickness measurements with a different test rig using a
 327 rectangular tank made of acrylic resin Perspex (width= 110 mm, length = 200 mm, wall thickness=5 mm
 328 and Height= 50 mm). The US-KEY and a Technisonic transducer model IPM-0102-HR 1MHz were used. The
 329 same method of validation with silicone oil was followed with distilled water. This was used to validate
 330 the ultrasonic technique for film thicknesses between 2 and 6 mm. This test rig is also capable of
 331 investigating the effect of inclination angle (incident wave angle) on measurement capability. Ultrasonic
 332 measurements are affected by reflections from interfaces which are not perpendicular to the incident
 333 wave. The further this angle is from the perpendicular the greater the effect on reflected wave detection
 334 sensitivity as the wave will be reflected away from the receiving transducer [21]. The angle was adjusted
 335 during experiments by lowering the test rig from one side. This angle was measured using a clinometer
 336 digital measurement. The other end of the test rig was fixed with a pivot joint so the test rig could be
 337 easily tilted. These experiments were performed on a film with a 6 mm thickness. The effect of inclination
 338 angle will be discussed in section 5.1.1.

339 *4.2. Dynamic Measurements:*

340 The capability of the ultrasonic pulse echo techniques to measure film thicknesses in a flowing test
 341 facilities was evaluated by comparing measurements with other established sensing technologies. A free
 342 falling liquid film annular flow test facility and an upward vertical annular flow test facility as shown in
 343 Figure 10 and Figure 11 respectively were used with water as the liquid phase.



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Figure 10: Schematic Diagram of a falling film annular flow test facility.

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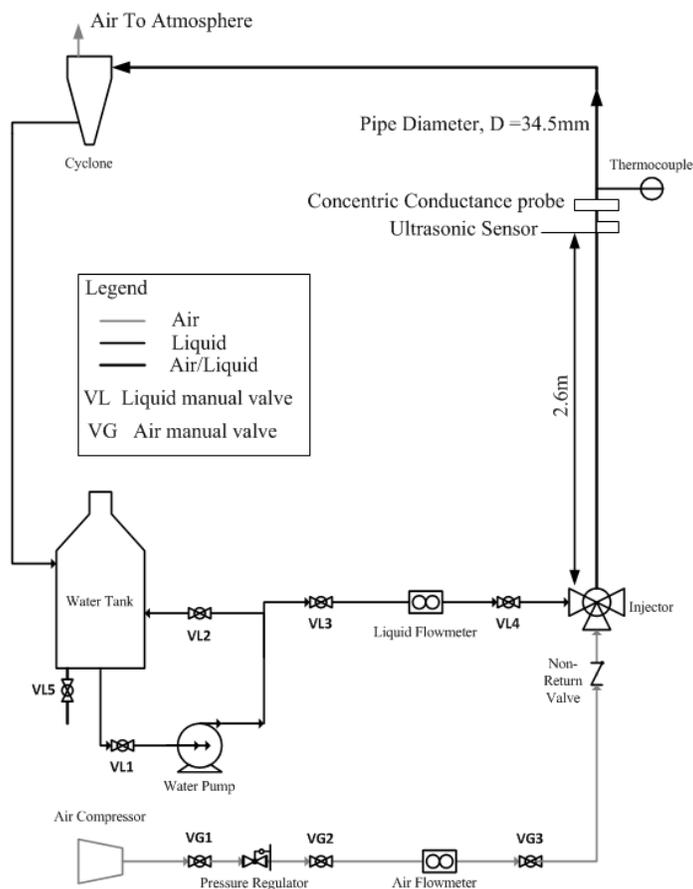
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The free falling liquid film annular flow test facility (Figure 10) has a vertical test section made of acrylic resin (Perspex™) with a 127 mm internal diameter and a length of 5 m. Water was used as the working fluid and there was no gas flow. The test section was connected to a water storage tank. The water was pumped from the water tank using a centrifugal pump and controlled by a manual control valve and a bypass valve to deliver the desired liquid flow rate through a rotameter. The water flow rate was measured by the rotameter (MBP Industries Ltd) with an accuracy of $\pm 5\%$ of full scale. A liquid distributor at the top of the test section was used to ensure a uniform liquid film around the test section. The experiments were performed at ambient temperature ($\sim 20^\circ\text{C}$) and atmospheric pressure and temperature was measured using a T-type thermocouple during all experiments. The ultrasonic measurements were compared with the measurements of a MPFS which was mounted at the lower end of the test section. The ultrasonic sensor and the MPFS were located at 320 cm (25.2D) and 350 cm (27.6D) from the bottom of liquid distributor respectively. The experiments were conducted at different liquid Reynold numbers (Re_l) ranging from 618 to 1670. $Re_l = \rho_l u_{sl} \delta / \mu_l = \rho_l Q_l / \pi D \mu_l$, where $u_{sl} = Q_l / \pi D \delta$, ρ_l is liquid density, u_{sl} is liquid superficial velocity, Q_l is liquid volumetric flowrate, D is pipe internal diameter and μ_l is the dynamic liquid viscosity. The length scale used to calculate the liquid Reynolds number is the mean liquid film thickness.

363 The Multi Pin Film Sensor (MPFS) operates on measurements of the electrical conductance between two
 364 electrodes in contact with the liquid film. The MPFS utilised was based on the design of [43]. This is similar
 365 to other conductance measurement techniques that have been used in literature [43, 44] except that it
 366 has the capability to record measurements in 10 axial locations instead of only one. The MPFS used has
 367 64 measurement locations in the circumferential direction and results from the US system were compared
 368 with the MPFS measurement in the same circumferential location.



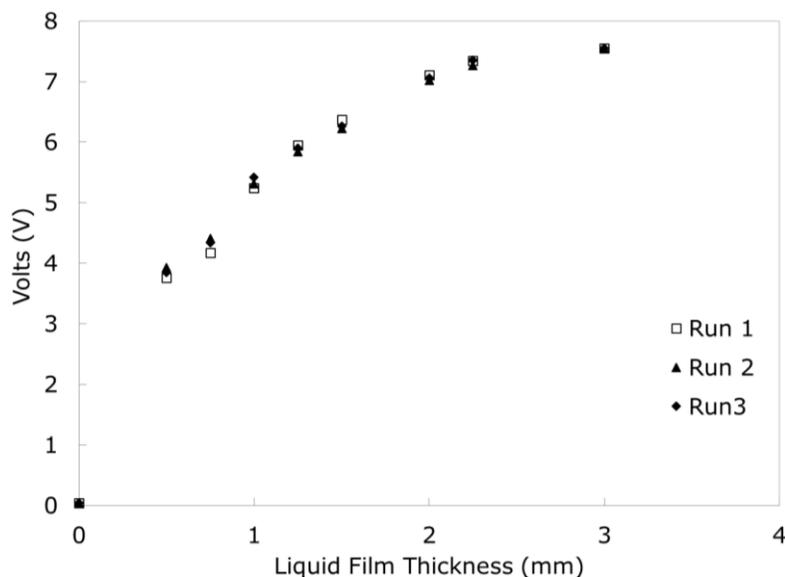
369

370 Figure 11: Schematic Diagram of upward vertical annular flow test facility.

371 The upward vertical annular flow test facility (Figure 11) has a height of 4 m with a 34.5 mm inner
 372 diameter and a test section made of acrylic resin (Perspex™). Both liquid and gas flow rate were measured
 373 using a calibrated rotameter (MBP Industries Ltd) with an accuracy of $\pm 5\%$. A conical injector system was
 374 used to achieve an annular flow regime similar to the one used by Zhao et al. [45]. The liquid was injected
 375 from the side and the gas from the center to create a uniform liquid film around the boundary of the wall.
 376 The liquid was injected at four different injection points at the same liquid rate to generate a film around
 377 the internal surface of the pipe wall with equal thickness. The airline was equipped with a non-return
 378 valve to prevent the flow of water into the gas rotameters. The air/liquid mixture was separated at the
 379 top using a cyclone separator. The air was vented to the atmosphere while the water was fed back into
 380 the storage tank.

381 In these experiments the results of the ultrasonic technique were compared with the results from the
382 concentric conductance probe. The concentric probe operates by relating the film thickness to
383 conductance across two electrodes. The concentric probe works on the same principle as MPFS but was
384 designed to measure the instantaneous film thickness at only four circumferential positions in one axial
385 location. The probe was designed and constructed by Zhao et al. [45] who used it to measure the film
386 thickness in a pipe of diameter 34.5 mm. This probe has also been used by researchers including Azzopardi
387 [46] and Wolf [47] to study multiphase flow. The ultrasonic probe was located in the same circumferential
388 location as one of the 4 concentric probes and separated axially by 70mm from the concentric probe due
389 to flange arrangement. The experiments were conducted at a fixed liquid superficial velocity of 0.089 m/s
390 and different gas superficial velocities ranging from 17.83 to 35.66 m/s.

391 The MPFS and the concentric probe were all calibrated using the same method. This involved inserting
392 different known diameters of non-conducting solid rods (PVC) inside the sensor in which the remaining
393 annulus was filled with water. The water simulates a film of known thickness that can be related to the
394 measured probe output voltage. These rods were machined with high precision to have a uniform
395 diameter. The calibration was repeated three times to ensure the annulus gap represented the expected
396 film thickness. The rod was centered at the bottom using a base block and at the top using a guide. The
397 calibration curves for the concentric probe is shown in Figure 12.



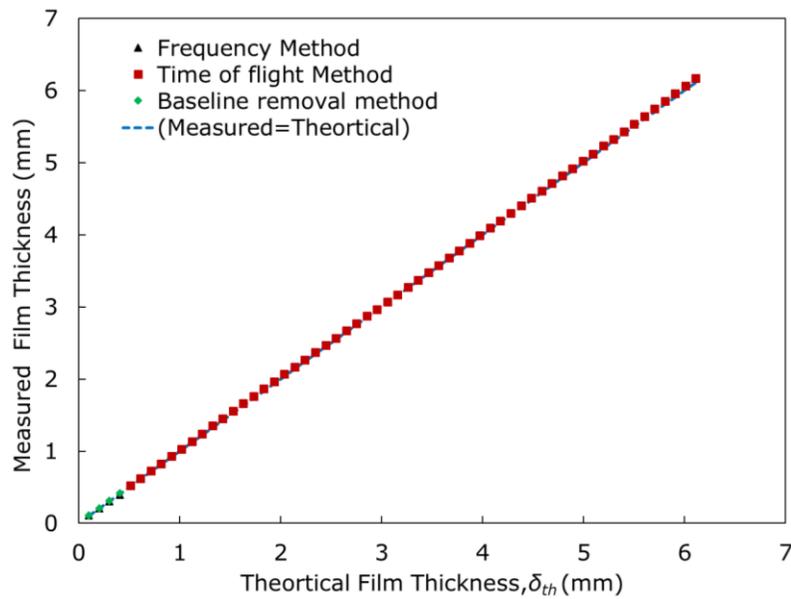
398
399 Figure 12: Calibration curve of the concentric probe. The plot shows the voltage measurements for three
400 repetitions.

401
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405 **4. Experiment Results and Discussion:**

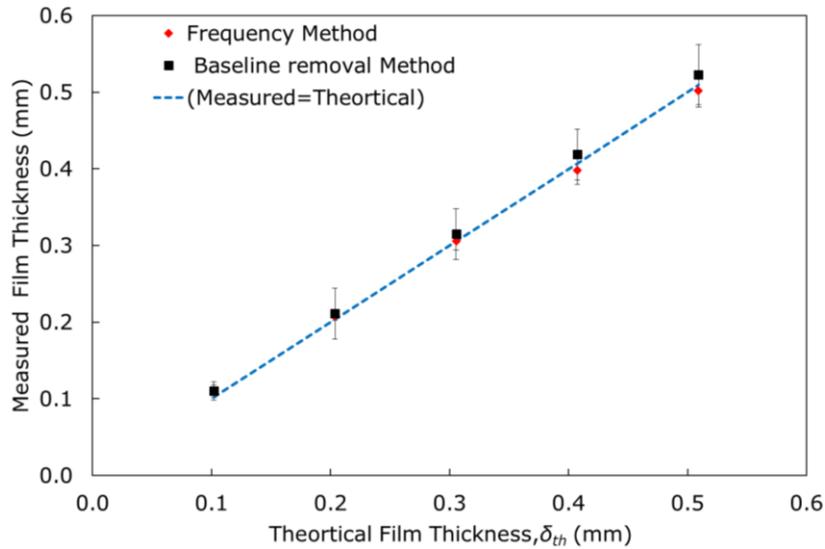
406 *5.1 Static Measurements*

407 Figures 13 to 15 show the comparisons of the mean film thicknesses of silicone oil and water obtained by
408 the ultrasonic methods and theoretical calculations (Equation 4) in a static fluid system. Figure 13 and 14
409 both show results from experiments in silicone oil but the range of film thicknesses is much lower in Figure
410 14 (0.1 – 0.5 mm), to demonstrate the capabilities of ultrasonic techniques at thinner film thicknesses.
411 For all experiments, the measurements were repeated three times to understand variability and at a
412 temperature of $20^{\circ}\text{C} \pm 0.2^{\circ}\text{C}$. The maximum standard deviation error of the mean at each measurement
413 point between repeated tests was 0.03 mm for both fluids. The TOF method was used for film thicknesses
414 greater than 0.5 mm. Both frequency and baseline removal methods were used for film thicknesses less
415 than 0.5 mm. The standard deviation error was calculated by dividing the standard deviation by the square
416 root of number of repeated points.



417

418 Figure 13: Ultrasonic pulse echo validation results for different processing methods against theoretical
419 calculations (Equation 1) using silicone oil with maximum standard deviation error of 0.03 mm.

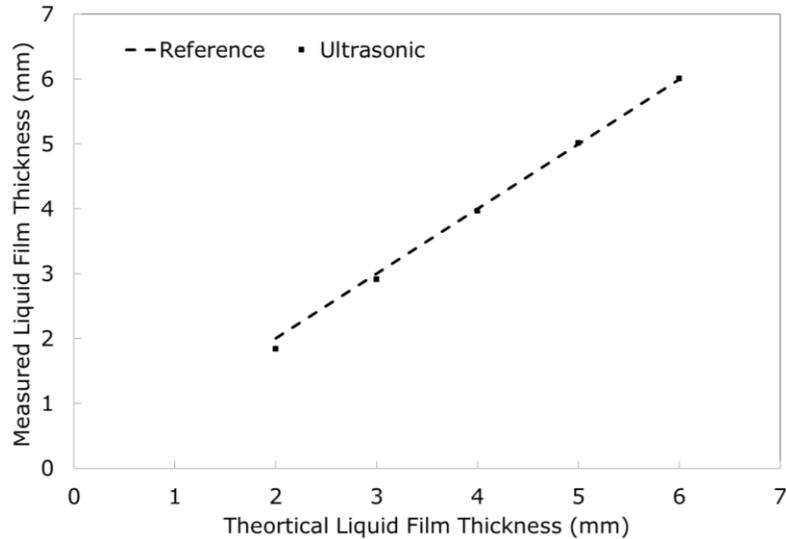


420

421 Figure 14: Ultrasonic pulse echo validation results in silicone oil for the frequency domain and baseline
 422 removal methods. These are compared to theoretical calculations (Equation 4) based on the volume of
 423 fluid added.

424 From Figures 13 and 14, the ultrasonic technique shows good agreement with the theoretical value for
 425 the film thickness calculated using the known volume of silicone oil added and equation 2. The
 426 temperature of the silicone oil was recorded and its speed of sound calculate using equation 5. The film
 427 thickness measurements between 0.1 mm and 0.5 mm were calculated using the frequency domain and
 428 baseline removal methods whereas the larger film thicknesses were calculated using the TOF method.

429 The static results for water are shown in Figure 15. The TOF method was used to calculate these film
 430 thicknesses. The temperature of the water was recorded and equation 6 was used to calculate its speed
 431 of sound. Equation 2 was then used to calculate the film thickness which was compared to the theoretical
 432 value calculated using the known volume of fluid added and the dimensions of the cylindrical test section.
 433 The measured values in Figure 15 for thinner films (2mm and 3mm) are slightly deviated from the
 434 calculated value by a maximum relative deviation of 2% due to potential errors in fluid volume, and the
 435 speed of sound and temperature measurement accuracy in laboratory conditions. However, it should be
 436 noted that there is a better agreement when the film thickness increases. This is due to the improved
 437 accuracy of the volume measurements of the liquid, at higher volumes. In general, the ultrasonic results
 438 show good agreement with values obtained theoretically.



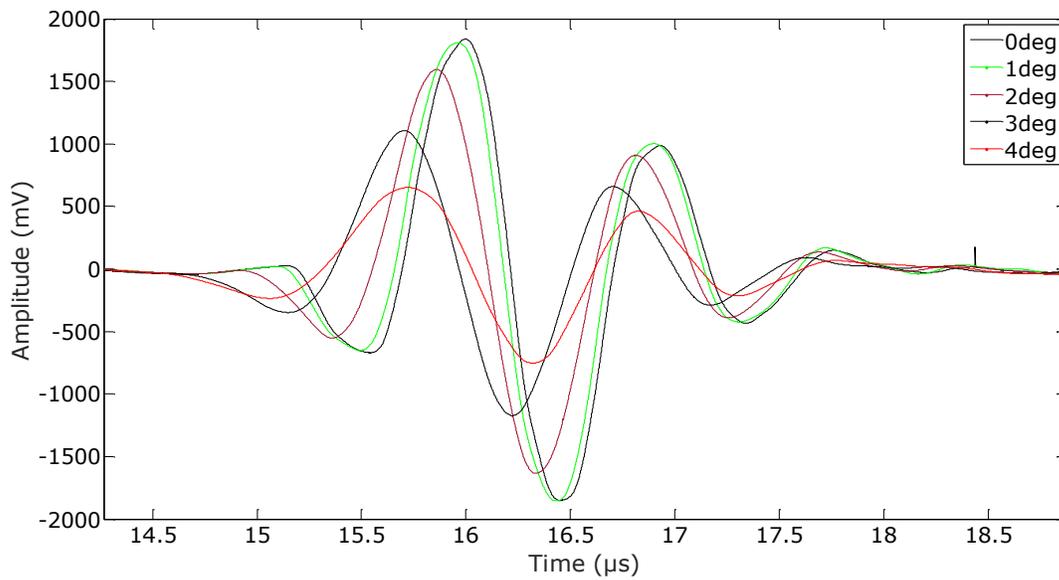
439

440 Figure 15: Ultrasonic pulse echo validation results for the time of flight method against theoretical
 441 calculations using water.

442 *5.1.1 Effect of Inclination Angle on Ultrasonic Measurement:*

443 As discussed, the received ultrasonic reflections are affected by the angle of the incident waves, which
 444 was highlighted as a challenge by Serizawa et al. [21]. Therefore, the effects of the incident wave angle
 445 (inclination) was investigated up to 4 degrees. This angle was the upper limit as the liquid was completely
 446 removed from the sensor above 4 degrees. These experiments were performed using the rectangular test
 447 rig at a 6mm liquid film thickness and a 1 MHz transducer. The detection of the reflected signal from the
 448 liquid film/air interface depends on the transducer diameter according to Serizawa et al. [21] and all
 449 transducers used in this work had the same diameter of 8mm. Figure 16 shows that the amplitude of the
 450 reflected signal decreased as the inclination angle increased, this is because a proportion of the reflected
 451 signal is not received by the transducer due to reflecting from a non-perpendicular interface. It was also
 452 observed that as the inclination angle increased, the measured time of flight reduced affecting the film
 453 thickness measurements. This is in agreement with the observations of Serizawa et al. [21] who used an
 454 inclined solid surface placed in water to simulate the reflection interface. Annular flow generally features
 455 a base film and the presence of disturbance waves. The amplitude and frequency of these disturbance
 456 waves increases as either the gas velocity or volume of water increases [9]. We believe the effects of
 457 inclination angle on reflected ultrasonic signals will therefore be less when there are less or smaller
 458 disturbance waves which is often the case when the films are thinner and the flow less turbulent.

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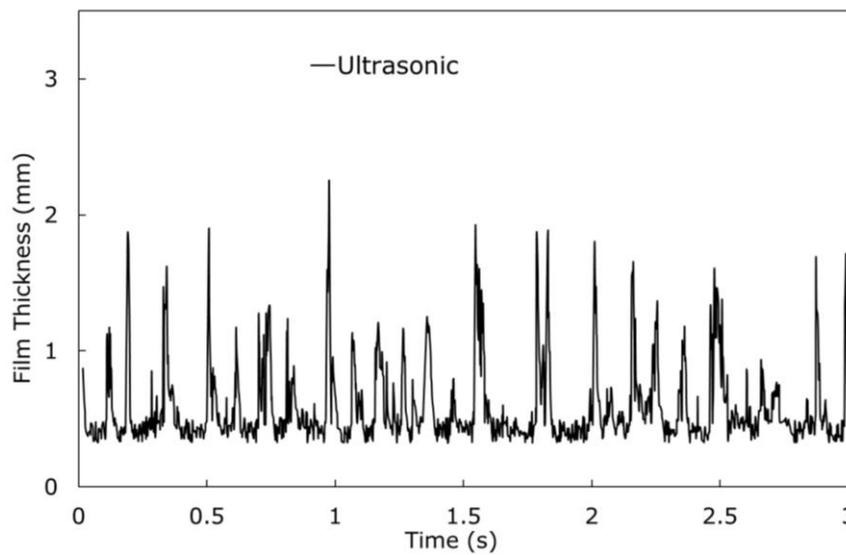
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Figure 16: Effects of inclination angle on the received ultrasonic signal.

462 *5.2 Dynamic Measurements*

463 *5.2.1 Falling films*

464 Figures 17 and 18 show the instantaneous measurement of the liquid film thickness at liquid Reynolds
 465 number 618 using ultrasonic and Multi Pin Film Sensor (MPFS) techniques for a falling film annular flow
 466 experiment. There was a vertical spatial separation of 300 mm between the two sensors. The
 467 measurement techniques show a good agreement with film thicknesses varying between 0.5 and 2.5 mm.

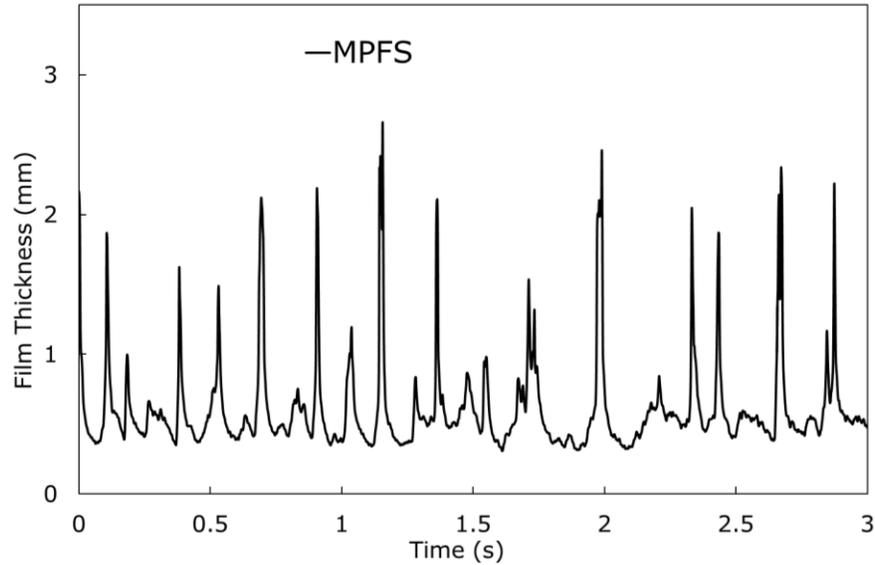


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Figure 17: Instantaneous variation of the film thickness using Ultrasonic technique at liquid Reynolds number 618.

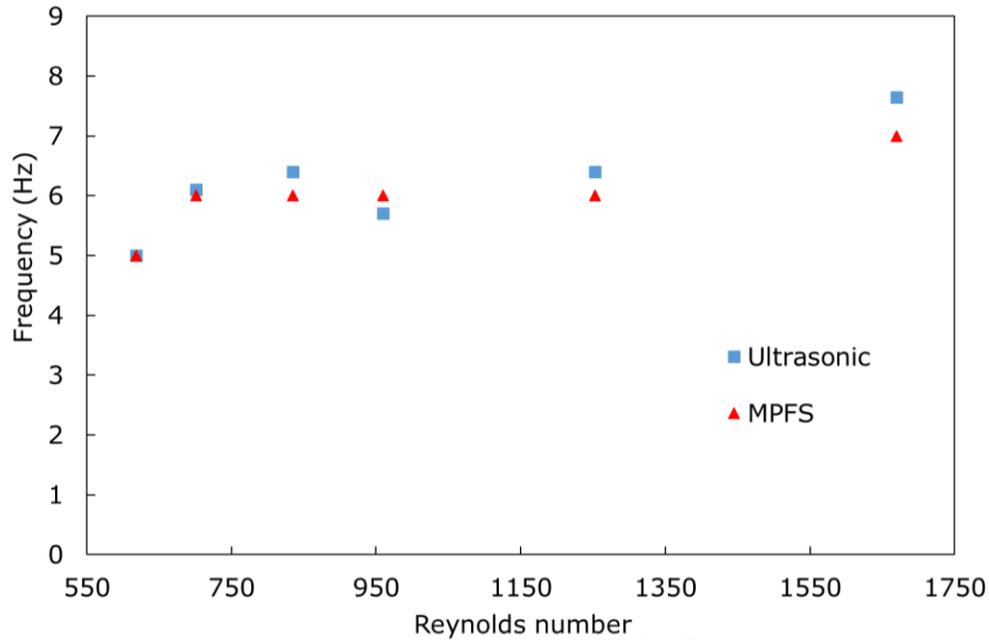
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471

472 Figure 18: Instantaneous variation of the film thickness using MPFS at liquid Reynolds number
 473 618.

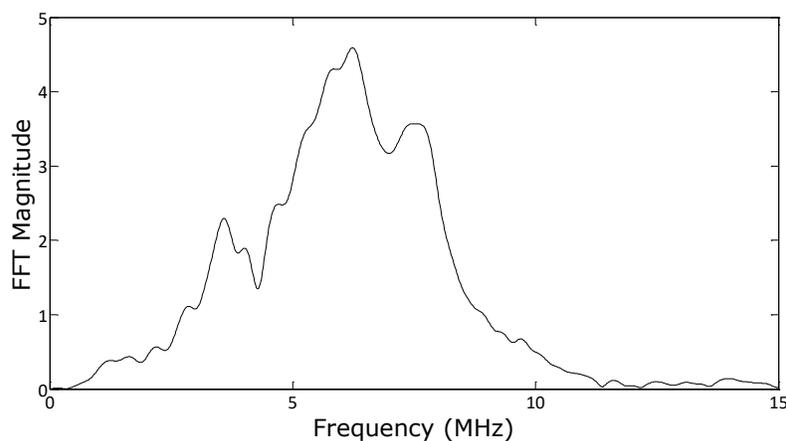
474 The frequency of the surface waves in the time series film thickness measurements were calculated using
 475 a Power Spectral Density (PSD) for both measurement data sets. The Power Spectral Density (PSD) was
 476 obtained using Welch's method within MATLAB. In the Welch's method, the time series signal is divided
 477 into small overlapping segments where spectrum analysis using a FFT is computed for each segment
 478 before the average spectral estimate for all segments is obtained. In the current analysis, the length of
 479 each segment is 500 data points with a 50% overlap between them. The power spectral density of both
 480 techniques for different Reynolds number ranged from 618 to 1670 and are shown in Figure 19. Both
 481 techniques were able to measure the frequency of the variation in film thickness and showed good
 482 agreement with each other. The film thickness exhibits a frequency ranging from 5 Hz to 8 Hz and generally
 483 increased with higher liquid Reynolds number.



484

485 Figure 19: Power Spectral Density (PSD) of the film thickness measurements using MPFS and ultrasonic
 486 techniques at different liquid Reynolds numbers.

487 Applying the frequency domain method in wavy films is challenging due to moving surfaces and results in
 488 many spectral peaks requiring significant post processing and leading to unreliable results as indicated in
 489 Figure 20. Further development is required to enhance the capabilities of the frequency domain method
 490 to operate on wavy films. The data obtained by the frequency domain method was not used in the current
 491 comparisons between the ultrasonic technique and the MPFS. Instead, the baseline removal and time of
 492 flight methods were used for calculating the instantaneous film thicknesses.

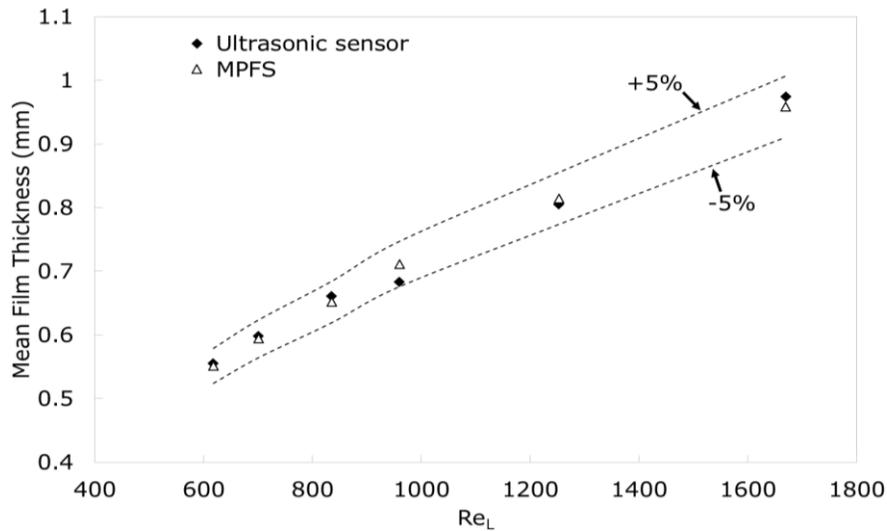


493

494 Figure 20: Spectrum Wavy Signal results after applying frequency method on a dynamic wavy film.

495 In terms of the mean film thickness, the data obtained by the ultrasonic measurements showed good
 496 agreement with the Multi Pin Film Sensor (MPFS) with a relative deviation less than $\pm 5\%$ between them.

497 Figure 21 shows the comparison of mean liquid film thickness measurements between the MPFS and the
 498 ultrasonic measurements at different liquid Reynolds numbers. Both techniques show the expected trend
 499 where the measured film thickness increased as the liquid Reynolds number increased. The results in
 500 Figure 21 are consistent with those of Karapantios et al. [48] and Salazar and Marschall [49] which show
 501 that an increase in liquid Reynolds number increases the mean film thickness in falling film systems. The
 502 liquid Reynolds number is proportional to the volumetric flow rate. Therefore an increase in Re_l results
 503 in a larger volume of water in the pipe and a larger mean film thickness. The results in Figure 21 also
 504 indicate two regions of different gradients, the first below a liquid Reynolds number of 1000 and second
 505 above it. This is most likely the result of a linear thin film transitioning to a larger wavy film. Interestingly
 506 the largest difference between the results from ultrasonic and MPFS measurements were at a liquid
 507 Reynolds value of 1000 where this transition occurs. Here we believe the MPFS is showing the correct
 508 value and there is an error with reading from the ultrasonic sensor caused by the transition from linear
 509 thin film flow to wavy film flow.



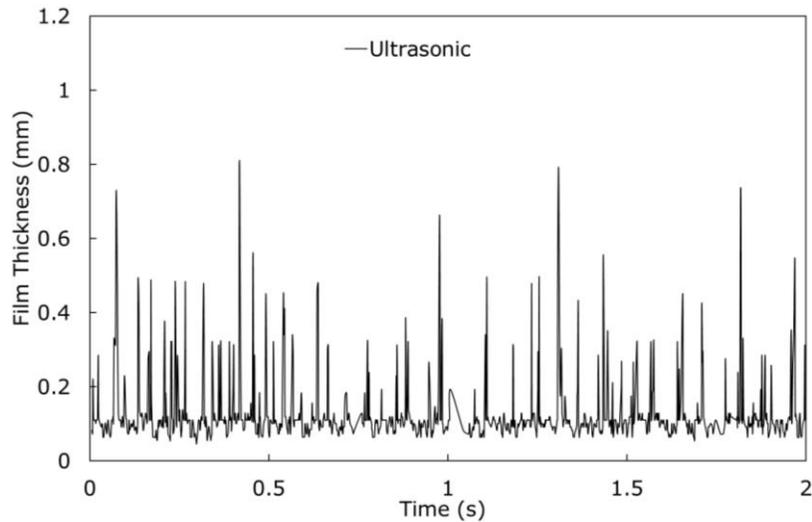
510
 511 Figure 21: Mean film thickness between Ultrasonic and MPFS using water with a relative deviation less
 512 than $\pm 5\%$ between them.

513 5.2.2 Upward annular flow

514 In the upward vertical annular flow experiments, the time series measurements of film thicknesses
 515 calculated by the ultrasonic technique showed similar trends to that measured by the concentric
 516 conductance probe for the same experimental parameters (Figures 22 and 23). In these experiments there
 517 was an axial spatial separation of 70 mm between the two sensors. The film thickness measurements
 518 recorded using the ultrasonic technique were calculated using the baseline removal and TOF methods.
 519 This was performed to check the capability of baseline removal method for measuring film thicknesses
 520 less than 0.5 mm on a flowing test facility.

521 The power spectral density was used to calculate the frequency of the surface waves for both techniques
 522 at a liquid superficial velocity of 0.089 m/s and different gas superficial velocities ranging from 17.83 to

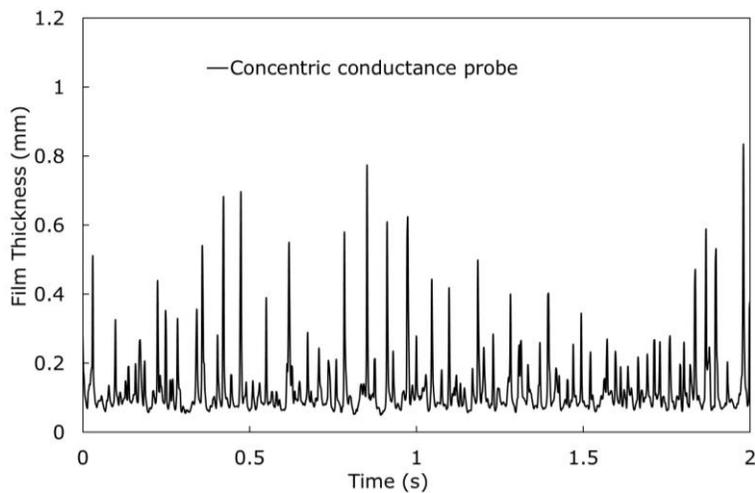
523 35.66 m/s (Figure 24). Both techniques were able to measure the variation of the film thickness frequency
524 and agreed with each other. The frequency of the variation in film thickness increases with increasing gas
525 superficial velocities from 7 Hz to 18 Hz.



526

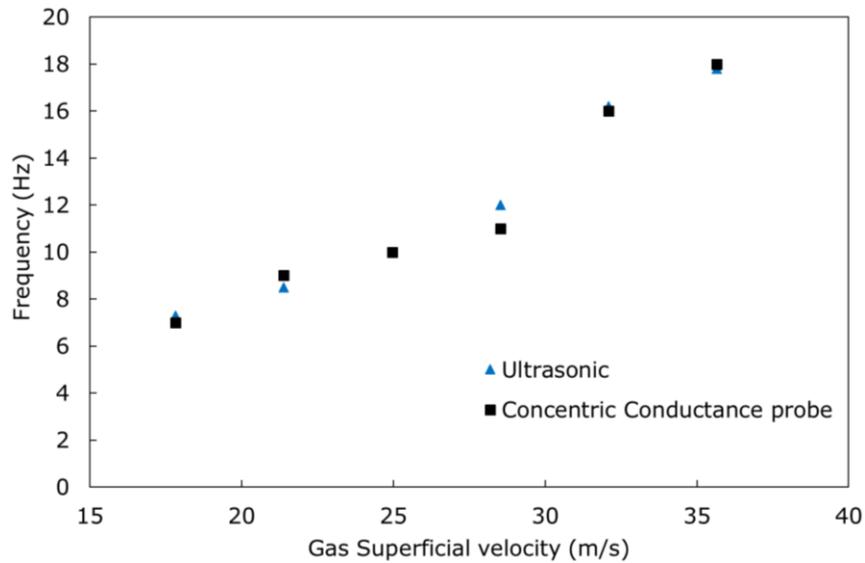
527 Figure 22: Instantaneous variation of the film thickness using the ultrasonic technique at water and gas
528 superficial velocities of 0.089 m/s and 35.66 m/s respectively.

529



530

531 Figure 23: Instantaneous variation of the film thickness using the concentric conductance probe at water and gas
532 superficial velocities of 0.089 m/s and 35.66 m/s respectively.



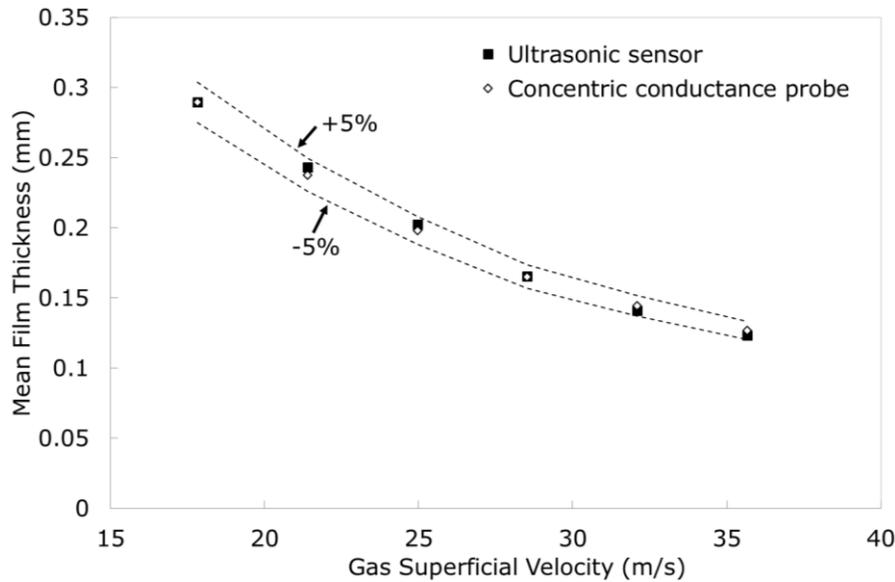
533

534 Figure 24: Power Spectral Density (PSD) of the film thickness measurements using the concentric probe
 535 and ultrasonic technique at different gas superficial velocities and water superficial velocity of 0.089
 536 m/s.

537 The results in Figure 24 indicate that an increase in gas superficial velocity results in an increase in wave
 538 frequency. When the gas and liquid meet at the inlet section the liquid phase is broken down into high
 539 frequency, low amplitude waves due to the shearing of the gas phase. These waves have irregular
 540 velocities and will coalesce with other low amplitude waves as the flow develops [9]. Increasing gas
 541 flowrate increases the interfacial shear and the frequency and velocity of these small waves resulting in
 542 a higher degree of coalescence and the formation of a higher frequency of disturbance waves. These
 543 results are consistent with the the work of Chu and Dukler [50], Azzopardi [46] and Vasques et al. [9].
 544 The ultrasonic technique and concentric conductance probe technique also showed excellent agreement
 545 in term of the mean film thickness measurement with a relative deviation less than $\pm 5\%$ between them.
 546 Both techniques showed the expected trend where the measured film thickness decreased as the gas
 547 superficial velocity increased at fixed liquid superficial velocity (Figure 25).

548

549



550

551 Figure 25: Mean film thicknesses measured using the ultrasonic and concentric conductance techniques
 552 at water superficial velocity of 0.089 m/s with a relative deviation less than $\pm 5\%$ between them.

553 Both static and dynamic measurements show the capabilities of the ultrasonic technique for measuring
 554 thin film thicknesses using different signal processing methods. The results also highlights the capability
 555 of the baseline removal method for measuring the film thickness when the reflected signals were
 556 overlapped in time. Increasing the data acquisition rate will improve the temporal resolution of measured
 557 film thicknesses whilst enabling a more accurate calculation of the average film thickness. More data
 558 points would also enable characteristics of the instantaneous liquid film to be studied in greater detail in
 559 the flowing test facilities. Figure 25 shows that an increase in gas superficial velocity reduces the mean
 560 film thickness which again is caused by the increase in interfacial shear and consistent with the results
 561 reported by Chu and Dukler [50], Belt et al. [17] and Vasques et al. [9].

562 **5. Conclusion:**

563 In this work, an ultrasonic measurement technique was implemented to measure dynamic film
 564 thicknesses between 0.1 mm and 6 mm in liquid-gas systems for silicone oil and water. The ultrasonic
 565 measurements were evaluated in static and dynamic environments. It is demonstrated that ultrasonic
 566 techniques have the capability to measure the instantaneous liquid film thickness in conducting and non-
 567 conducting mediums. The results obtained were in good agreement with theoretical predictions and
 568 simultaneous measurements from established sensing technologies (MPFS and concentric probe). For the
 569 experimental work in static systems errors due to the temperature dependence of the speed of sound,
 570 fluid volume and geometry did not appear to influence the results significantly. The experimental results
 571 for instantaneous and mean film thickness in upwards and downwards annular flow showed good
 572 agreement between the ultrasonic and conductance sensors with results consistent to those reported in
 573 the literature.

574 The baseline removal method of Park et al. [41] was used as the signal processing method when the
575 ultrasonic reflected signals were overlapped in the time domain. This method showed good agreement
576 with an existing frequency domain method, yet requires less computational processing and is simpler to
577 implement. Interestingly the greatest difference between the ultrasonic and established measurement
578 results occurred where changes in the flow behaviour were observed.

579 This work demonstrates the potential of ultrasonic pulse echo techniques for measuring the film thickness
580 in annular flow using a variety of signal processing methods. However challenges still remain when the
581 liquid gas interface experiences large waves due to the angle the incident ultrasonic waves are reflected.

582 **Acknowledgements**

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584 of the research facilities utilized in this work and for his constructive comments for the research activities
585 undertaken.

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